

CMI700 Series

Control your plating/coating process with the most advanced bench-top system that we have ever designed

Ergonomic design, a large backlit LCD display, and Oxford Instruments technology and experience have been brought together to produce the **CMI700 Series**. This easy-to-use microprocessor driven instrument delivers precise measurements at the touch of a button. Specially designed to handle the needs of platers, coaters, and quality professionals, the **CMI700** was built to withstand even the most hostile work environments.

The **CMI700** combines ease-of-use with high inspections productivity and accuracy with a display that is clearly visible

from several feet away and from virtually any angle.

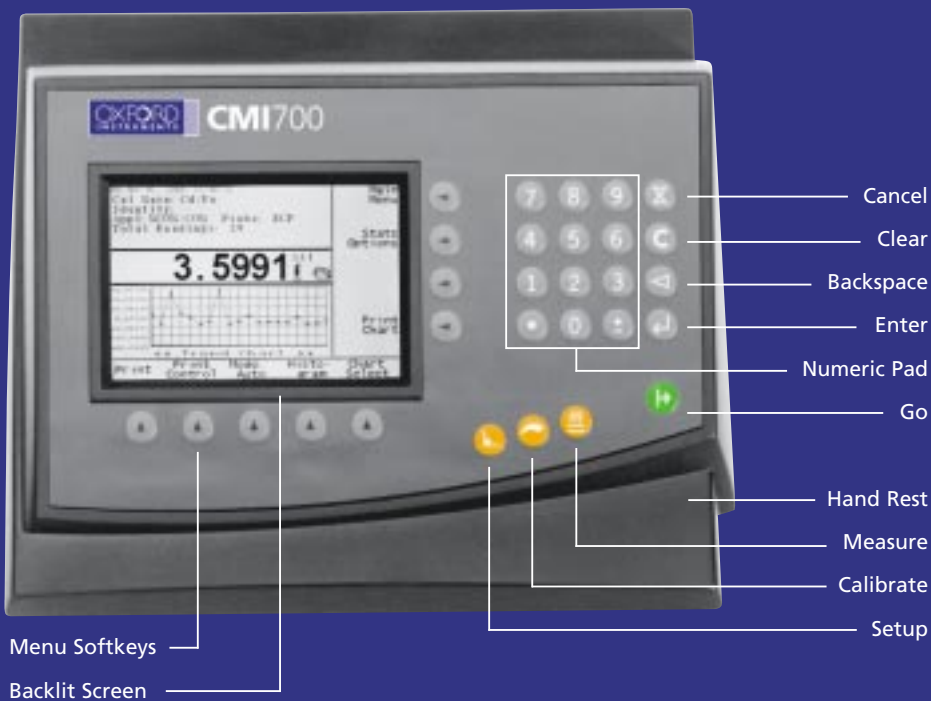
The **CMI700** provides high tech solutions for non-destructive coating/plating thickness measurement for both non-magnetic coatings over magnetic substrates, non-conductive coatings over conductive substrates, and electroplated nickel over magnetic substrates.

Like all our instruments, it's backed by the Oxford Instruments Group. We guarantee superior service before and after your order.

- Platers: Zn, Cd, Ni, Cu etc
- Coaters: Paint, Powder and Anodize
- Quality: Ideal for incoming inspection of coated or plated parts



CMI700 Series coating thickness measurement system



CMI700 Series Specifications

Magnetic Induction: Conforms to methods ASTM B499 & B530, DIN 50981, ISO 2178 and BS 5411 Parts 9 & 11

Eddy Current: Conforms to methods ASTM B244 & B259, DIN 50984, ISO 2360 and BS 5411 Part 3

Memory: 8000 bytes, non volatile

Accuracy: $\pm 1\% \pm 0.1 \mu\text{m}$ referred to reference standards

Outputs: Parallel printer port and RS232C serial port

Unit Conversions: Select from mils, μm , μin , mm, in., or % as units for display

Weight: 6 Lbs. (2.79 kg)

Dimensions: (W) 11.5" (29.21 cm)
(D) 10.5" (26.67 cm)
(H) 5.5" (13.97 cm)

Display: Large LCD 480(H) x 320(V) pixels, backlit, wide angle view

Statistics: Mean, high and low, standard deviation, % deviation and CPK

Charts: Histogram, trend, x-Bar and r

Eddy Current Mode	Range	Magnetic Mode	Range
Non-Conductive on Conductive	0-40.0 mils (0-1000 μm)	Non-Magnetic on Magnetic Steel	0-50.0 mils (0-1250 μm)
Zinc on Steel	0-1.50 mils (0-37.5 μm)		
Cadmium on Steel	0-1.50 mils (0-37.5 μm)	Electroplated Nickel on Non-Magnetic	0-5.00 mils (0-125 μm)
Copper on Steel	0-1.50 mils (0-37.5 μm)		
Nickel on Steel (electroplated)	0-3.00 mils (0-75.0 μm)		

Call Sales Support for more information regarding the **CMI700 Series**.

CMI700 Series instruments comply with ISO/IEC Guide 25 requirements.

Multiple Security Levels

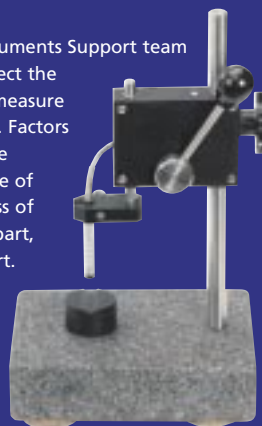
CE Mark

Probe Samples and Information



Probes are required with all **CMI700 Series** systems. Despite their size and simple appearance, probes are high precision electromechanical assemblies that play a critical role in your ability to measure parts accurately.

The Oxford Instruments Support team will help you select the probe that will measure your application. Factors involved in probe selection are type of coating, thickness of coating, size of part, and shape of part. Optional probe guides provide precision control.



Probe Guide (optional)

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OIA/52/A/0202

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